

**Search Notes**

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Junghwa M. Im

Applicant(s)/Patent under  
Reexamination

BAYAN ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
updated	previous search	3/5/2005	JMI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated previous search	3/5/2005	JMI